



NUP1301

Ultra low capacitance ESD protection array

Rev. 01 — 11 May 2009

Product data sheet

1. Product profile

1.1 General description

Ultra low capacitance ElectroStatic Discharge (ESD) protection array in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package designed to protect one signal line in rail-to-rail configuration from the damage caused by ESD and other transients.

1.2 Features

- ESD protection of one signal line (rail-to-rail configuration)
- Ultra low diode capacitance: $C_d = 0.6$ pF
- Very low reverse leakage current: ≤ 30 nA
- ESD protection up to 30 kV
- IEC 61000-4-2; level 4 (ESD)
- IEC 61000-4-5 (surge); $I_{PP} = 11$ A at $t_p = 8/20$ μ s
- AEC-Q101 qualified

1.3 Applications

- Telecommunication networks
- Video line protection
- Microcontroller protection
- I²C-bus protection
- Antenna power supply
- Analog audio
- Class-D amplifier

1.4 Quick reference data

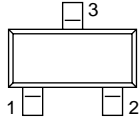
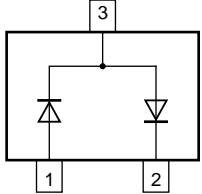
Table 1. Quick reference data

$T_{amb} = 25$ °C unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|------------------|---------------------------------|-----------------------------|-----|-----|------|------|
| Per diode | | | | | | |
| V_{RRM} | repetitive peak reverse voltage | | - | - | 80 | V |
| C_d | diode capacitance | $f = 1$ MHz; $V_R = 0$ V | - | 0.6 | 0.75 | pF |
| I_R | reverse current | $V_R = 80$ V | - | - | 100 | nA |

2. Pinning information

Table 2. Pinning

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|-----------------|----------------|--|---|
| 1 | GND | ground |  |  |
| 2 | V _{CC} | supply voltage | | |
| 3 | I/O | input/output | | |

006aaa763

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|-------------|---------|--|---------|
| | Name | Description | Version |
| NUP1301 | - | plastic surface-mounted package; 3 leads | SOT23 |

4. Marking

Table 4. Marking

| Type number | Marking code ^[1] |
|-------------|-----------------------------|
| NUP1301 | LJ* |

- [1] * = -: made in Hong Kong
 * = p: made in Hong Kong
 * = t: made in Malaysia
 * = W: made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|---------------------------------|---------------------------------|-----|-----|------|
| Per diode | | | | | |
| V _{RRM} | repetitive peak reverse voltage | | - | 80 | V |
| V _R | reverse voltage | | - | 80 | V |
| I _F | forward current | | [1] | 215 | mA |
| I _{FRM} | repetitive peak forward current | t _p ≤ 1 ms; δ ≤ 0.25 | - | 500 | mA |

Table 5. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-------------------|-------------------------------------|--|--------|------|------------------|
| I_{FSM} | non-repetitive peak forward current | square wave | [2] | | |
| | | $t_p = 1 \mu s$ | - | 4 | A |
| | | $t_p = 1 ms$ | - | 1 | A |
| | | $t_p = 1 s$ | - | 0.5 | A |
| Per device | | | | | |
| P_{PP} | peak pulse power | $t_p = 8/20 \mu s$ | [3][4] | - | 220 W |
| I_{PP} | peak pulse current | $t_p = 8/20 \mu s$ | [3][4] | - | 11 A |
| P_{tot} | total power dissipation | $T_{amb} \leq 25 \text{ }^\circ\text{C}$ | [5][6] | - | 250 mW |
| T_j | junction temperature | | - | 150 | $^\circ\text{C}$ |
| T_{amb} | ambient temperature | | -55 | +150 | $^\circ\text{C}$ |
| T_{stg} | storage temperature | | -65 | +150 | $^\circ\text{C}$ |

[1] Pulse test: $t_p \leq 300 \mu s$; $\delta \leq 0.02$.[2] $T_j = 25 \text{ }^\circ\text{C}$ prior to surge.[3] Non-repetitive current pulse 8/20 μs exponential decay waveform according to IEC 61000-4-5.

[4] Measured from pin 3 to pins 1 and 2 (pins 1 and 2 are connected).

[5] Single diode loaded.

[6] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

Table 6. ESD maximum ratings

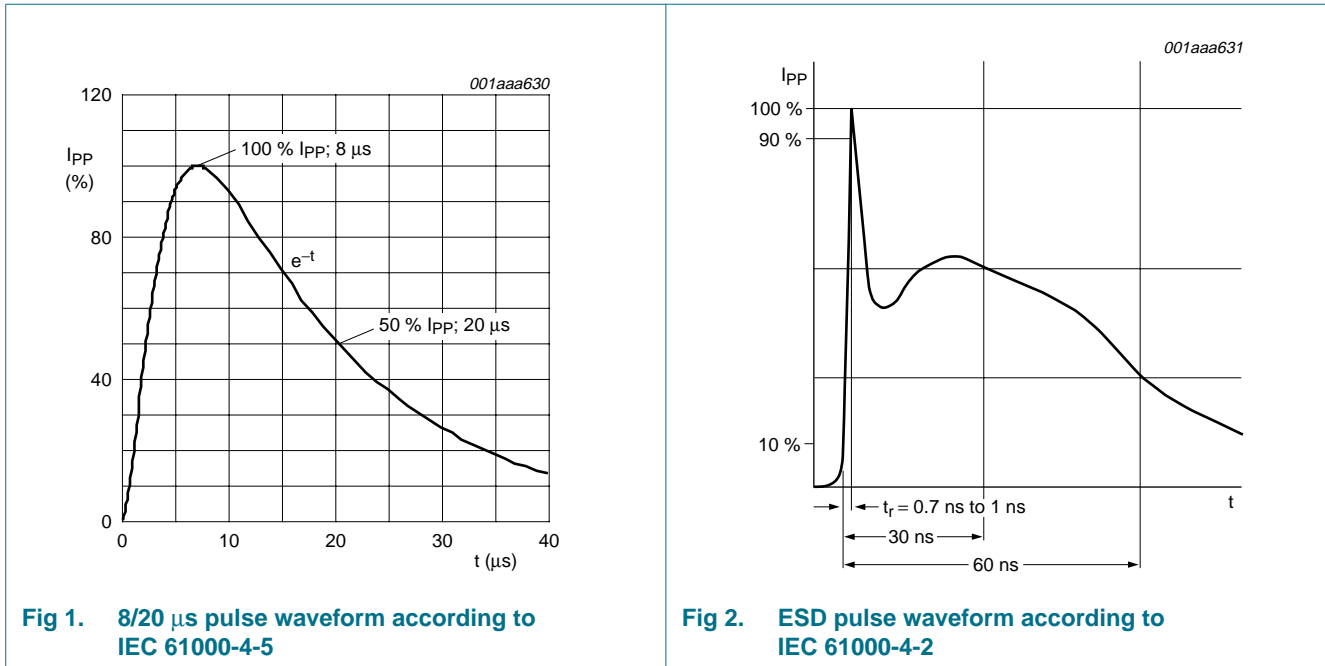
| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|---------------------------------|-----------------------------------|--------|-----|-------|
| V_{ESD} | electrostatic discharge voltage | IEC 61000-4-2 (contact discharge) | [1][2] | - | 30 kV |
| | | machine model | - | 400 | V |
| | | MIL-STD-883 (human body model) | - | 10 | kV |

[1] Device stressed with ten non-repetitive ESD pulses.

[2] Measured from pin 3 to pins 1 and 2 (pins 1 and 2 are connected).

Table 7. ESD standards compliance

| Standard | Conditions |
|--|---------------------------------|
| IEC 61000-4-2; level 4 (ESD) | > 15 kV (air); > 8 kV (contact) |
| MIL-STD-883; class 3B (human body model) | > 8 kV |



6. Thermal characteristics

Table 8. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------|--|-------------|--------|-----|-----|------|
| Per device | | | | | | |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | in free air | [1][2] | - | 500 | K/W |
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | | - | - | 360 | K/W |

[1] Single diode loaded.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

7. Characteristics

Table 9. Electrical characteristics

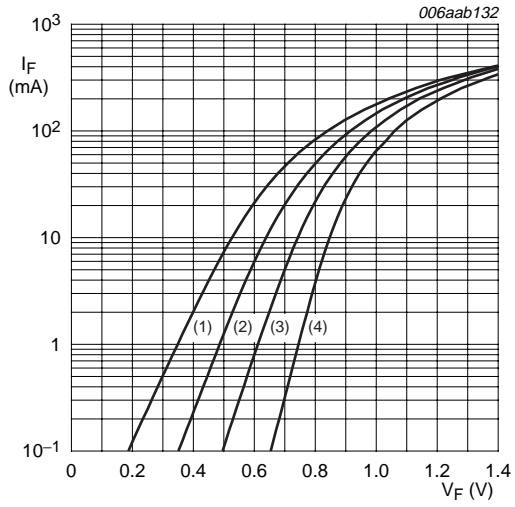
$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------|-------------------|---|--------|-----|------|---------------|
| Per diode | | | | | | |
| V_{BR} | breakdown voltage | $I_R = 100\text{ }\mu\text{A}$ | 100 | - | - | V |
| V_F | forward voltage | | [1] | | | |
| | | $I_F = 1\text{ mA}$ | - | - | 715 | mV |
| | | $I_F = 10\text{ mA}$ | - | - | 855 | mV |
| | | $I_F = 50\text{ mA}$ | - | - | 1 | V |
| | | $I_F = 150\text{ mA}$ | - | - | 1.25 | V |
| I_R | reverse current | | | | | |
| | | $V_R = 25\text{ V}$ | - | - | 30 | nA |
| | | $V_R = 80\text{ V}$ | - | - | 100 | nA |
| | | $V_R = 25\text{ V};$ $T_j = 150\text{ }^{\circ}\text{C}$ | - | - | 25 | μA |
| | | $V_R = 80\text{ V};$ $T_j = 150\text{ }^{\circ}\text{C}$ | - | - | 35 | μA |
| C_d | diode capacitance | $f = 1\text{ MHz}; V_R = 0\text{ V}$ | - | 0.6 | 0.75 | pF |
| Per device | | | | | | |
| V_{CL} | clamping voltage | $I_{PP} = 1\text{ A}$ | [2][3] | - | 3 | V |
| | | $I_{PP} = 11\text{ A}$ | [2][3] | - | 20 | V |

[1] Pulse test: $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0.02$.

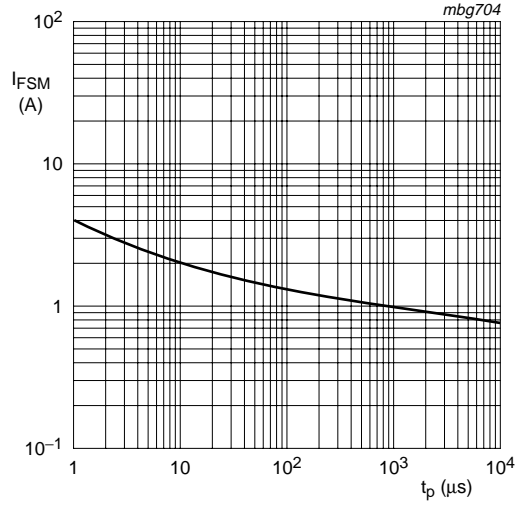
[2] Non-repetitive current pulse 8/20 μs exponential decay waveform according to IEC 61000-4-5.

[3] Measured from pin 3 to pins 1 and 2 (pins 1 and 2 are connected).



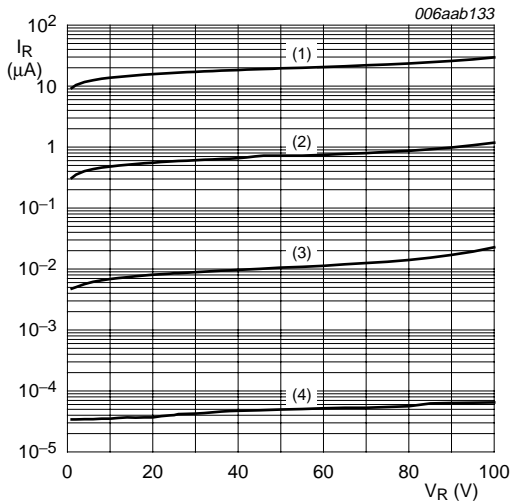
- (1) $T_{amb} = 150^\circ\text{C}$
- (2) $T_{amb} = 85^\circ\text{C}$
- (3) $T_{amb} = 25^\circ\text{C}$
- (4) $T_{amb} = -40^\circ\text{C}$

Fig 3. Forward current as a function of forward voltage; typical values



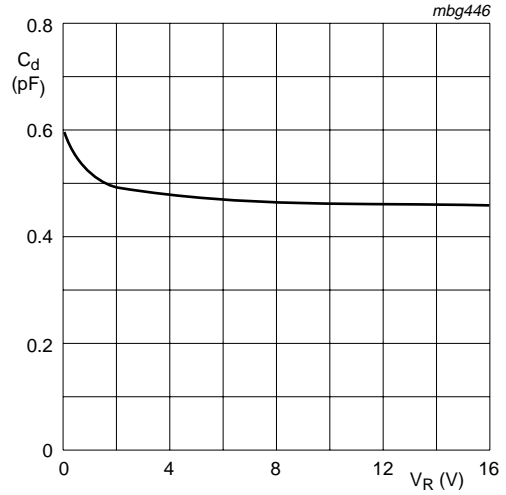
Based on square wave currents.
 $T_j = 25^\circ\text{C}$; prior to surge

Fig 4. Non-repetitive peak forward current as a function of pulse duration; typical values



- (1) $T_{amb} = 150^\circ\text{C}$
- (2) $T_{amb} = 85^\circ\text{C}$
- (3) $T_{amb} = 25^\circ\text{C}$
- (4) $T_{amb} = -40^\circ\text{C}$

Fig 5. Reverse current as a function of reverse voltage; typical values



$T_{amb} = 25^\circ\text{C}$; $f = 1\text{ MHz}$

Fig 6. Diode capacitance as a function of reverse voltage; typical values

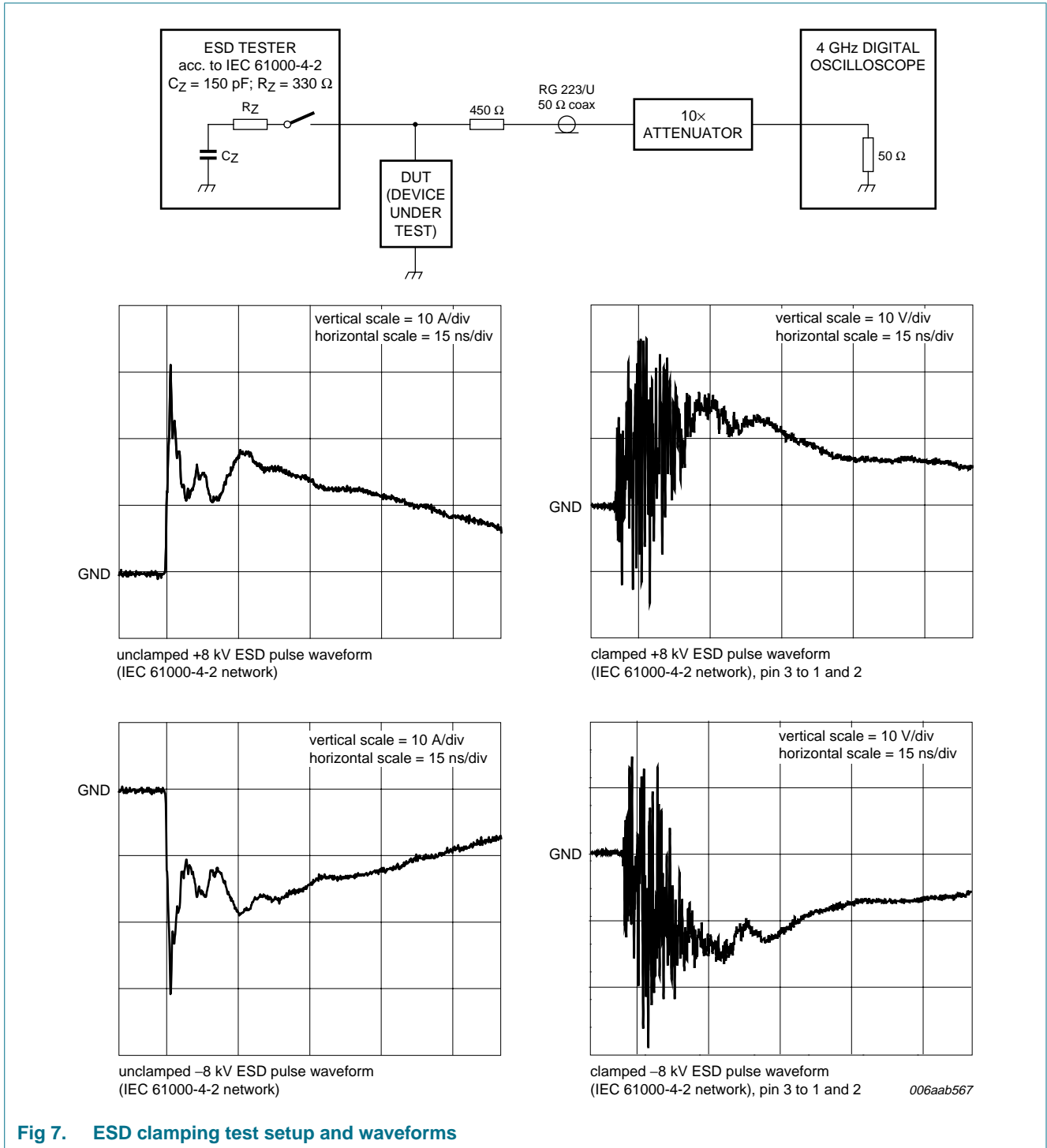


Fig 7. ESD clamping test setup and waveforms

8. Application information

Protection of a single (high-speed) data line in rail-to-rail configuration. The protected data line is connected to pin 3. Pin 1 is connected to ground (GND) and pin 2 is connected to the supply rail (supply voltage V_{CC} .) When the transient voltage exceeds the forward voltage drop of one diode, the transient is directed either to the supply rail or to GND. The advantages of these solutions are: low line capacitance (0.6 pF typically), fast response time, and low clamping voltage.

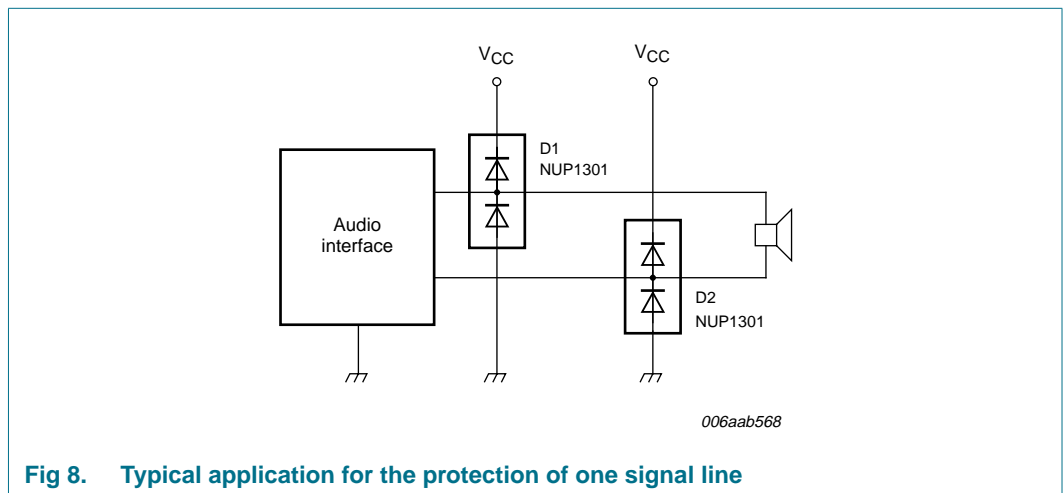


Fig 8. Typical application for the protection of one signal line

Circuit board layout and protection device placement:

Circuit board layout is critical for the suppression of ESD, Electrical Fast Transient (EFT) and surge transients. The following guidelines are recommended:

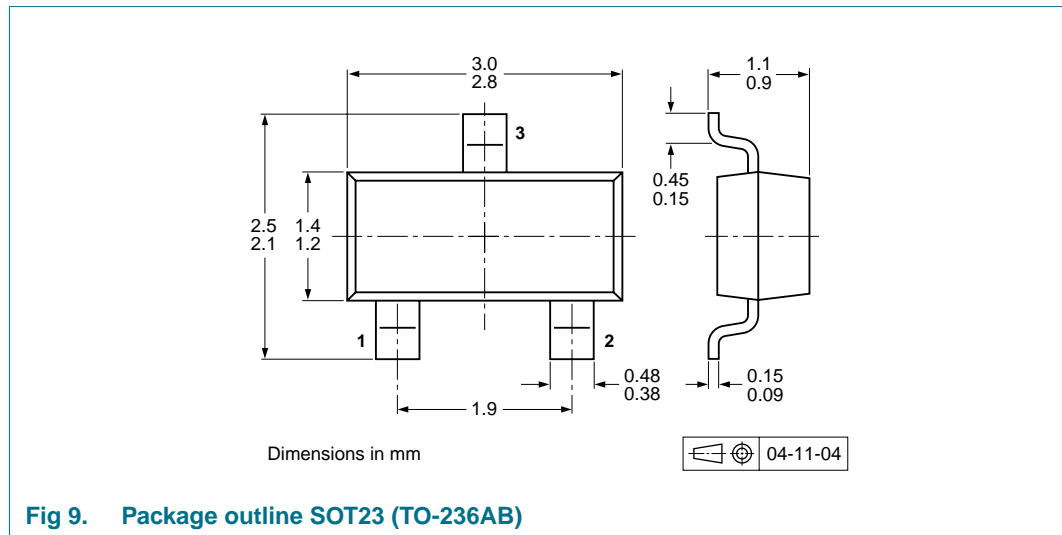
1. Place the NUP1301 as close to the input terminal or connector as possible.
2. The path length between the NUP1301 and the protected line should be minimized.
3. Keep parallel signal paths to a minimum.
4. Avoid running protected conductors in parallel with unprotected conductors.
5. Minimize all Printed-Circuit Board (PCB) conductive loops including power and ground loops.
6. Minimize the length of the transient return path to ground.
7. Avoid using shared transient return paths to a common ground point.
8. Ground planes should be used whenever possible. For multilayer PCBs, use ground vias.

9. Test information

9.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

10. Package outline



11. Packing information

Table 10. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.^[1]

| Type number | Package | Description | Packing quantity | |
|-------------|---------|--------------------------------|------------------|-------|
| | | | 3000 | 10000 |
| NUP1301 | SOT23 | 4 mm pitch, 8 mm tape and reel | -215 | -235 |

[1] For further information and the availability of packing methods, see [Section 15](#).

12. Soldering

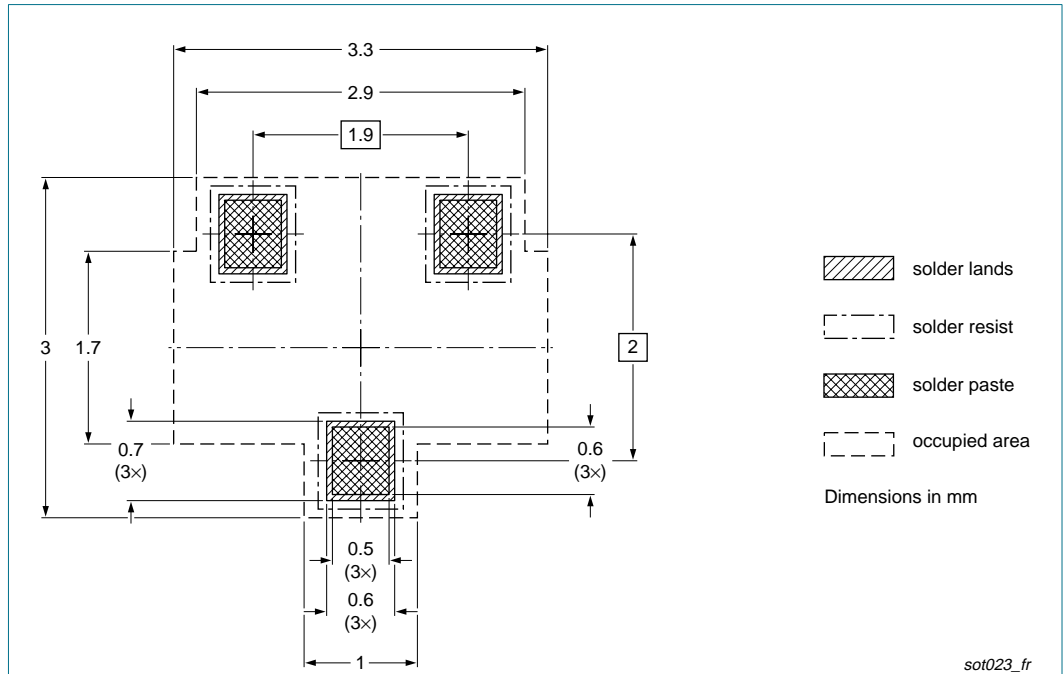


Fig 10. Reflow soldering footprint SOT23 (TO-236AB)

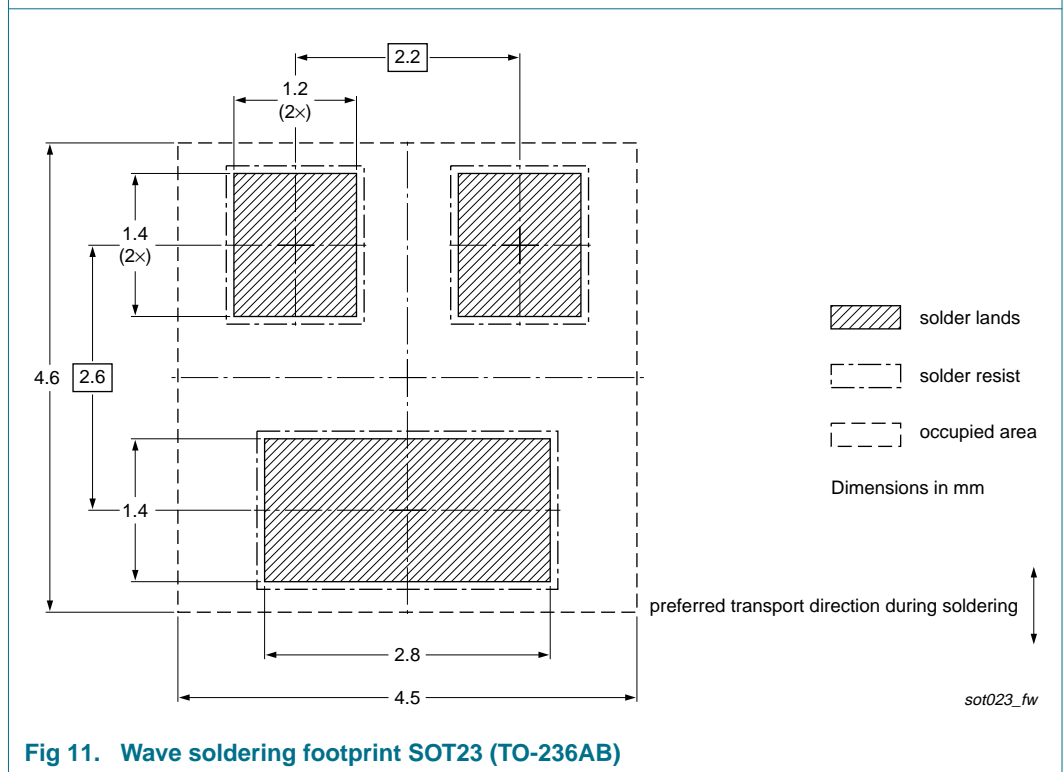


Fig 11. Wave soldering footprint SOT23 (TO-236AB)

13. Revision history

Table 11. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|-------------|--------------|--------------------|---------------|------------|
| NUP1301_1 | 20090511 | Product data sheet | - | - |

14. Legal information

14.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nexperia.com>.

14.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. Nexperia does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local Nexperia sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

14.3 Disclaimers

General — Information in this document is believed to be accurate and reliable. However, Nexperia does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — Nexperia reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — Nexperia products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of a Nexperia product can reasonably be expected to result in personal injury, death or severe property or environmental

damage. Nexperia accepts no liability for inclusion and/or use of Nexperia products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. Nexperia makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — Nexperia products are sold subject to the general terms and conditions of commercial sale, as published at <http://www.nexperia.com/profile/terms>, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by Nexperia. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

14.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

15. Contact information

For more information, please visit: <http://www.nexperia.com>

For sales office addresses, please send an email to: salesaddresses@nexperia.com

16. Contents

| | | |
|-----------|--|-----------|
| 1 | Product profile | 1 |
| 1.1 | General description | 1 |
| 1.2 | Features | 1 |
| 1.3 | Applications | 1 |
| 1.4 | Quick reference data | 1 |
| 2 | Pinning information | 2 |
| 3 | Ordering information | 2 |
| 4 | Marking | 2 |
| 5 | Limiting values | 2 |
| 6 | Thermal characteristics | 4 |
| 7 | Characteristics | 5 |
| 8 | Application information | 8 |
| 9 | Test information | 8 |
| 9.1 | Quality information | 8 |
| 10 | Package outline | 9 |
| 11 | Packing information | 9 |
| 12 | Soldering | 10 |
| 13 | Revision history | 11 |
| 14 | Legal information | 12 |
| 14.1 | Data sheet status | 12 |
| 14.2 | Definitions | 12 |
| 14.3 | Disclaimers | 12 |
| 14.4 | Trademarks | 12 |
| 15 | Contact information | 12 |
| 16 | Contents | 13 |

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

[Nexperia:](#)

[NUP1301,215](#)